	Application/Control No.	Applicant(s)/Pater	nt Under
Notice of References Cited	10/582,807	Reexamination NAMITA ET AL.	
Notice of Neierenees office	Examiner	Art Unit	
	Versal Ohan	0054	Page 1 of 1

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Applicant(s)/Patent Under

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,550,383	04-2003	Kitai, Mitsuo	101/180
*	В	US-2002/0023558	02-2002	Kusunoki, Kenji	101/221
*	υ	US-5,259,310	11-1993	Fischer, Christian M. M.	101/248
	D	US-			
	Е	US-			
	F	US-			
	G	US-		-	
	Н	US-		-	
	_	US-			
	J	US-			
	к	US-			
	L	US-			
	м	US-			

FOREIGN PATENT DOCUMENTS

FOREIGN PATENT DOCUMENTS						
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

NON DATENT DOCUMENTS

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